



TEST REPORT

Reference No...... : WTX23X12264039W002
Applicant : Descartes System Group Inc
Address : 105 Trafalgar Street, Floor 2 Floor 2, Nelson, 7010 New Zealand
Manufacturer : The same as Applicant
Address : The same as Applicant
Product Name : COREInsight BLE Beacon Tag
Model No...... : STD004
Standards : FCC PART 15.209
Date of Receipt sample : 2023-12-12
Date of Test..... : 2023-12-12 to 2023-12-23
Date of Issue : 2023-12-23
Test Report Form No. : WTX_FCC PART25_001
Test Result..... : Pass

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of approver.

Prepared By:

Waltek Testing Group (Shenzhen) Co., Ltd.

Address: 1/F., Room 101, Building 1, Hongwei Industrial Park, Liuxian 2nd Road,
Block 70 Bao'an District, Shenzhen, Guangdong, China

Tel.: +86-755-33663308 Fax.: +86-755-33663309 Email: sem@waltek.com.cn

Tested by:

Approved by:

Mike Shi

Silin Chen



TABLE OF CONTENTS

1. GENERAL INFORMATION	4
1.1 PRODUCT DESCRIPTION FOR EQUIPMENT UNDER TEST (EUT)	4
1.2 TEST STANDARDS.....	5
1.3 TEST METHODOLOGY	5
1.4 TEST FACILITY	5
1.5 EUT SETUP AND OPERATION MODE	6
1.6 MEASUREMENT UNCERTAINTY	7
1.7 TEST EQUIPMENT LIST AND DETAILS	8
2. SUMMARY OF TEST RESULTS.....	11
3. RADIATED SPURIOUS EMISSIONS	12
3.1 TEST PROCEDURE.....	12
3.2 BLOCK DIAGRAM OF TEST SETUP	12
3.3 TEST RECEIVER SETUP	13
3.4 CORRECTED AMPLITUDE & MARGIN CALCULATION.....	13
3.5 ENVIRONMENTAL CONDITIONS	13
3.6 SUMMARY OF TEST RESULTS.....	13
EXHIBIT 1 - TEST SETUP PHOTOGRAPHS.....	18

WALTEK



Report version

Version No.	Date of issue	Description
Rev.00	2023-12-23	Original
/	/	/

WALTEK



1. GENERAL INFORMATION

1.1 Product Description for Equipment Under Test (EUT)

General Description of EUT	
Product Name:	COREInsight BLE Beacon Tag
Trade Name:	/
Model No.:	STD004
Adding Model(s):	/
<i>Note: The test data is gathered from a production sample, provided by the manufacturer.</i>	

Technical Characteristics of EUT	
Rated Voltage:	Battery:DC3.6V
Battery Capacity:	2700mAh
Rated Power:	/
Power Adapter Model:	/
Lowest Internal Frequency:	32MHz
Highest Internal Frequency:	2480MHz
Classification of ITE:	Class B



1.2 Test Standards

The tests were performed according to following standards:

FCC Rules Part 15.209: Radiated emission limits; general requirements.

ANSI C63.10-2013: American National Standard for Testing Unlicensed Wireless Devices.

Maintenance of compliance is the responsibility of the manufacturer. Any modification of the product, which result in lowering the emission, should be checked to ensure compliance has been maintained.

1.3 Test Methodology

All measurements contained in this report were conducted with ANSI C63.10-2013, KDB 558074 D01 15.247 Meas Guidance v05r02. The equipment under test (EUT) was configured to measure its highest possible emission level. The test modes were adapted accordingly in reference to the Operating Instructions.

1.4 Test Facility

Address of the test laboratory

Laboratory: Waltek Testing Group (Shenzhen) Co., Ltd.

Address: 1/F., Room 101, Building 1, Hongwei Industrial Park, Liuxian 2nd Road, Block 70 Bao'an District, Shenzhen, Guangdong, China

FCC – Registration No.: 125990

Waltek Testing Group (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. The Designation Number is CN5010, and Test Firm Registration Number is 125990.

Industry Canada (IC) Registration No.: 11464A

The 3m Semi-anechoic chamber of Waltek Testing Group (Shenzhen) Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 11464A and the CAB identifier is CN0057.



1.5 EUT Setup and Operation Mode

The equipment under test (EUT) was configured to measure its highest possible emission. The test modes were adapted according to the operation manual for use, more detailed description as follows:

Test Mode List			
Test Mode	Description	Remark	Power Supply Mode
TM1	BLE	Radiated spurious emissions; BLE 2440MHz	Battery:DC3.6V

EUT Cable List and Details				
Cable Description	Length (m)	Shielded/Unshielded	With / Without Ferrite	With / Without Chip
/	/	/	/	/

Special Cable List and Details				
Cable Description	Length (m)	Shielded/Unshielded	With / Without Ferrite	With / Without Chip
/	/	/	/	/

Auxiliary Equipment List and Details			
Description	Manufacturer	Model	Serial Number
/	/	/	/



1.6 Measurement Uncertainty

Measurement uncertainty		
Parameter	Conditions	Uncertainty
Transmitter Spurious Emissions	Radiated	30-200MHz ±4.52dB
		0.2-1GHz ±5.56dB
		1-6GHz ±3.84dB
		6-26GHz ±3.92dB

WALTEK



1.7 Test Equipment List and Details

Fixed asset Number	Description	Manufacturer	Model	Serial No.	Cal Date	Due. Date
WTXE1041A 1001	Communication Tester	Rohde & Schwarz	CMW500	148650	2023-02-25	2024-02-24
WTXE1022A 1002	GSM Tester	Rohde & Schwarz	CMU200	114403	2023-02-25	2024-02-24
WTXE1005A 1005	Spectrum Analyzer	Agilent	N9020A	US471401 02	2023-02-25	2024-02-24
WTXE1084A 1001	Spectrum Analyzer	Agilent	N9020A	MY543205 48	2023-02-25	2024-02-24
WTXE1044A 1001	Signal Generator	Agilent	83752A	3610A014 53	2023-02-25	2024-02-24
WTXE1045A 1001	Vector Signal Generator	Agilent	N5182A	MY470702 02	2023-02-25	2024-02-24
WTXE1018A 1001	Power Divider	Weinschel	1506A	PM204	2023-02-25	2024-02-24
WTXE1045A 1001	Power Divider	RF-Lambda	RFLT4W5M18G	14110400 027	2023-02-25	2024-02-24
☐ Chamber A: Below 1GHz						
WTXE1005A 1003	Spectrum Analyzer	Rohde & Schwarz	FSP30	836079/03 5	2023-02-25	2024-02-24
WTXE1007A 1001	EMI Test Receiver	Rohde & Schwarz	ESVB	825471/00 5	2023-02-25	2024-02-24
WTXE1007A 1001	Amplifier	HP	8447F	2805A034 75	2023-02-25	2024-02-24
WTXE1010A 1007	Loop Antenna	Schwarz beck	FMZB 1516	9773	2021-03-20	2024-03-19
WTXE1010A 1006	Broadband Antenna	Schwarz beck	VULB9163	9163-333	2023-03-20	2026-03-19
☐ Chamber A: Above 1GHz						
WTXE1005A 1003	Spectrum Analyzer	Rohde & Schwarz	FSP30	836079/03 5	2023-02-25	2024-02-24
WTXE1007A 1001	EMI Test Receiver	Rohde & Schwarz	ESVB	825471/00 5	2023-02-25	2024-02-24
WTXE1065A 1001	Amplifier	C&D	PAP-1G18	14918	2023-02-25	2024-02-24
WTXE1010A 1005	Horn Antenna	ETS	3117	00086197	2021-03-19	2024-03-18
WTXE1010A 1010	DRG Horn Antenna	A.H. SYSTEMS	SAS-574	571	2021-03-19	2024-03-18



WTXE1003A 1001	Pre-amplifier	Schwarz beck	BBV 9721	9721-031	2023-02-25	2024-02-24
☐ Chamber B:Below 1GHz						
WTXE1010A 1006	Trilog Broadband Antenna	Schwarz beck	VULB9163(B)	9163-635	2021-04-09	2024-04-08
WTXE1038A 1001	Amplifier	Agilent	8447D	2944A104 57	2023-02-25	2024-02-24
WTXE1001A 1002	EMI Test Receiver	Rohde & Schwarz	ESPI	101391	2023-02-25	2024-02-24
☒ Chamber C:Below 1GHz						
WTXE1093A 1001	EMI Test Receiver	Rohde & Schwarz	ESIB 26	100401	2023-02-25	2024-02-24
WTXE1010A 1013-1	Trilog Broadband Antenna	Schwarz beck	VULB 9168	1194	2021-05-28	2024-05-27
WTXE1010A 1007	Loop Antenna	Schwarz beck	FMZB 1516	9773	2021-03-20	2024-03-19
WTXE1007A 1002	Amplifier	HP	8447F	2944A038 69	2023-02-25	2024-02-24
☒ Chamber C: Above 1GHz						
WTXE1093A 1001	EMI Test Receiver	Rohde & Schwarz	ESIB 26	100401	2023-02-25	2024-02-24
WTXE1103A 1005	Horn Antenna	POAM	RTF-118A	1820	2023-03-10	2026-03-09
WTXE1103A 1006	Amplifier	Tonscend	TAP01018050	AP22E806 235	2023-02-25	2024-02-24
WTXE1010A 1010	DRG Horn Antenna	A.H. SYSTEMS	SAS-574	571	2021-03-19	2024-03-18
WTXE1003A 1001	Pre-amplifier	Schwarzbeck	BBV 9721	9721-031	2023-02-25	2024-02-24
☐ Conducted Room 1#						
WTXE1001A 1001	EMI Test Receiver	Rohde & Schwarz	ESPI	101611	2023-02-25	2024-02-24
WTXE1002A 1001	Pulse Limiter	Rohde & Schwarz	ESH3-Z2	100911	2023-02-25	2024-02-24
WTXE1003A 1001	AC LISN	Schwarz beck	NSLK8126	8126-279	2023-02-25	2024-02-24
☒ Conducted Room 2#						
WTXE1001A 1004	EMI Test Receiver	Rohde & Schwarz	ESPI	101259	2023-02-25	2024-02-24
WTXE1003A	LISN	Rohde &	ENV 216	100097	2023-02-25	2024-02-24



1003		Schwarz				
------	--	---------	--	--	--	--

Software List			
Description	Manufacturer	Model	Version
EMI Test Software (Radiated Emission)*	Farad	EZ-EMC	RA-03A1
EMI Test Software (Conducted Emission Room 1#)*	Farad	EZ-EMC	RA-03A1
EMI Test Software (Conducted Emission Room 2#)*	SKET	EMC-I	V2.0

*Remark: indicates software version used in the compliance certification testing.

WALTEK



2. SUMMARY OF TEST RESULTS

Description of Test	Result
\$15.209 Radiated Spurious Emissions	Compliant

WALTEK

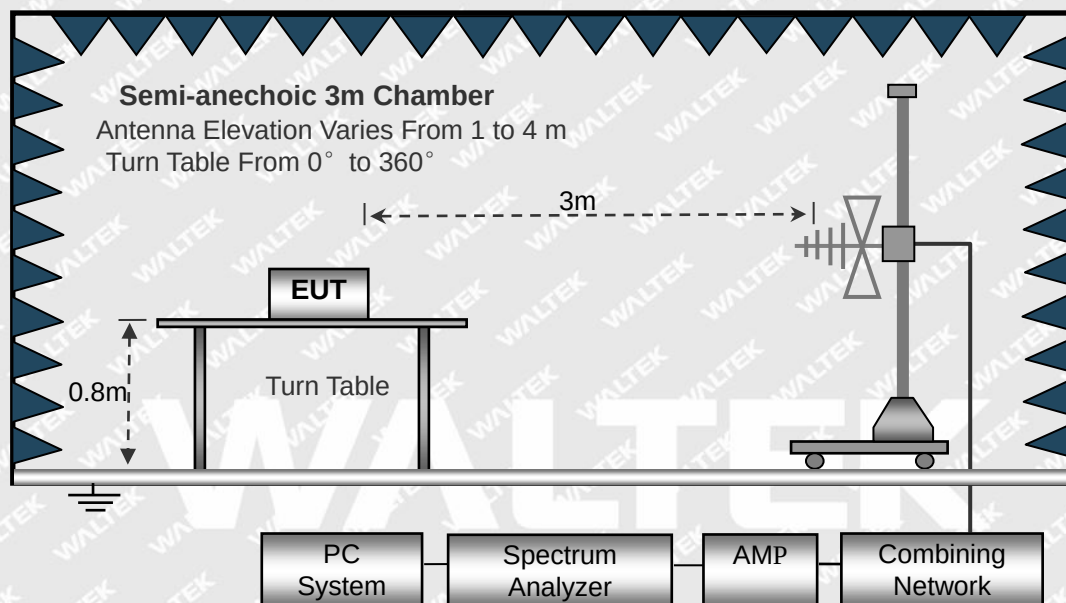


3. RADIATED SPURIOUS EMISSIONS

3.1 Test Procedure

The specification used was to FCC Part 15.209 limits. The limits used for FCC Part 15.209 for spurious emissions are (74dBuV/m peak & 54dBuV/m average).

3.2 Block Diagram of Test Setup





Reference No.: WTX23X12264039W002

3.3 Test Receiver Setup

Frequency :9kHz-30MHz

RBW=10KHz,

VBW =30KHz

Sweep time= Auto

Trace = max hold

Detector function = peak

Frequency :30MHz-1GHz

RBW=120KHz,

VBW=300KHz

Sweep time= Auto

Trace = max hold

Detector function = peak, QP

Frequency :Above 1GHz

RBW=1MHz,

VBW=3MHz(Peak), 10Hz(AV)

Sweep time= Auto

Trace = max hold

Detector function = peak, AV

3.4 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and the Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\text{Corr. Ampl.} = \text{Indicated Reading} + \text{Ant. Factor} + \text{Cable Loss} - \text{Ampl. Gain}$$

The “**Margin**” column of the following data tables indicates the degree of compliance with the applicable limit.

For example, a margin of -6dB μ V means the emission is 6dB μ V below the maximum limit. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Corr. Ampl.} - \text{FCC Part 15(or Part 25) Limit}$$

3.5 Environmental Conditions

Temperature:	22.5 °C
Relative Humidity:	54 %
ATM Pressure:	1011 mbar

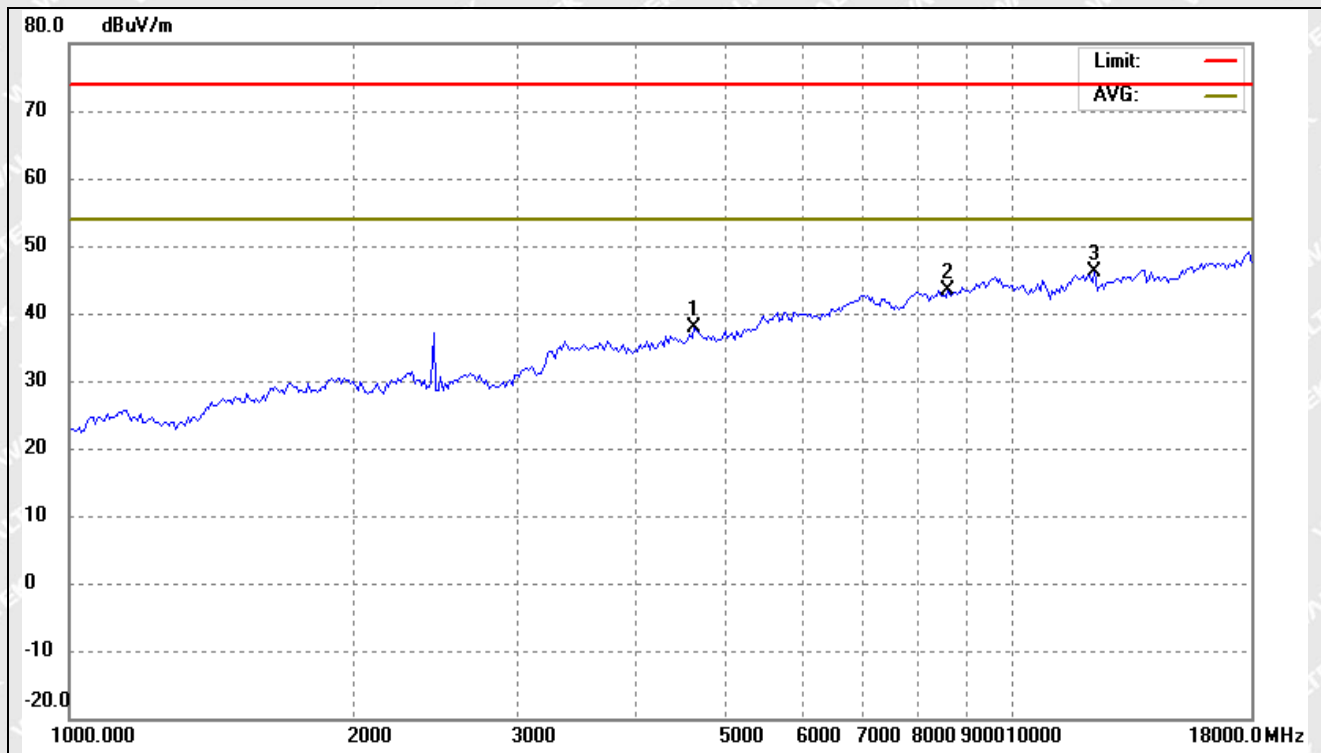
3.6 Summary of Test Results

Please find the results below:



Above 1GHz

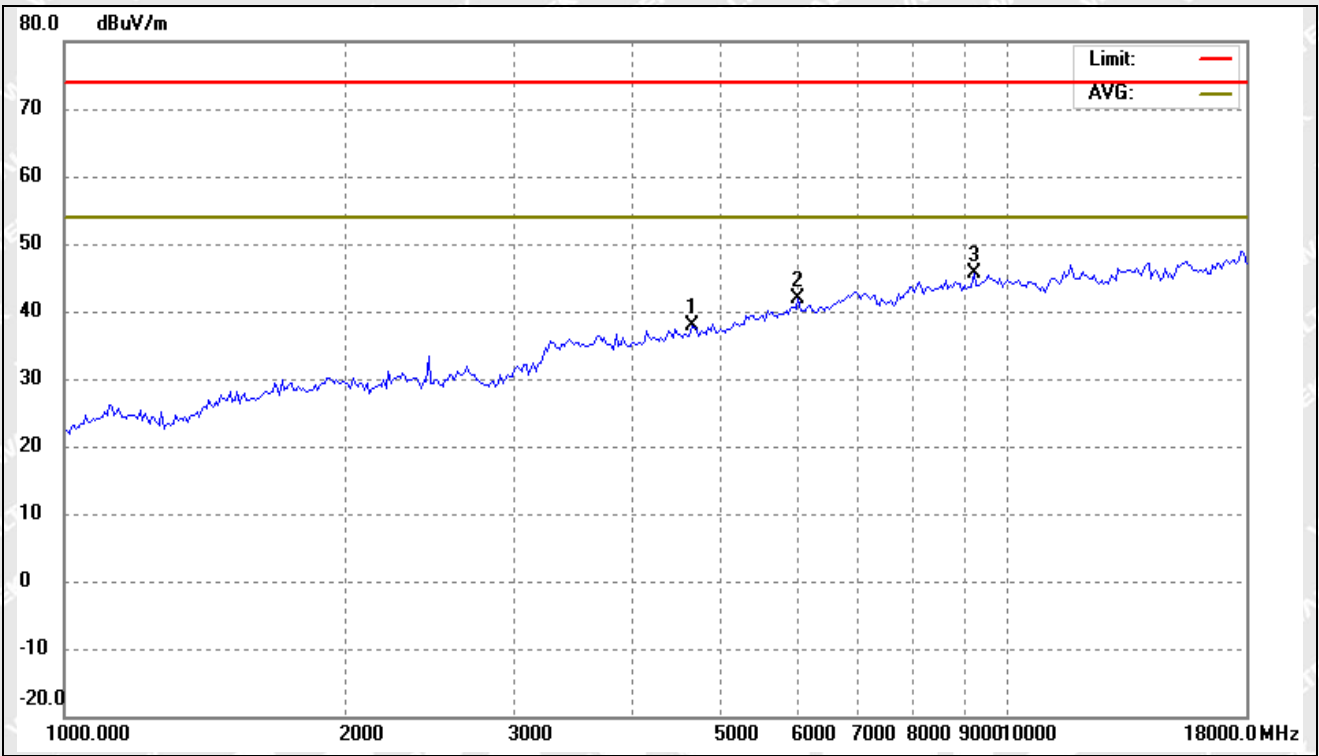
Test mode:	TM1	Polarity:	Horizontal
------------	-----	-----------	------------



No.	Frequency (MHz)	Reading (dBuV)	Correct (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree ()	Height (cm)	Remark
1	4614.367	50.94	-12.95	37.99	74.00	-36.01	-	-	peak
2	8575.881	48.51	-5.19	43.32	74.00	-30.68	-	-	peak
3	12281.304	46.80	-0.75	46.05	74.00	-27.95	-	-	peak



Test mode:	TM1	Polarity:	Vertical
------------	-----	-----------	----------

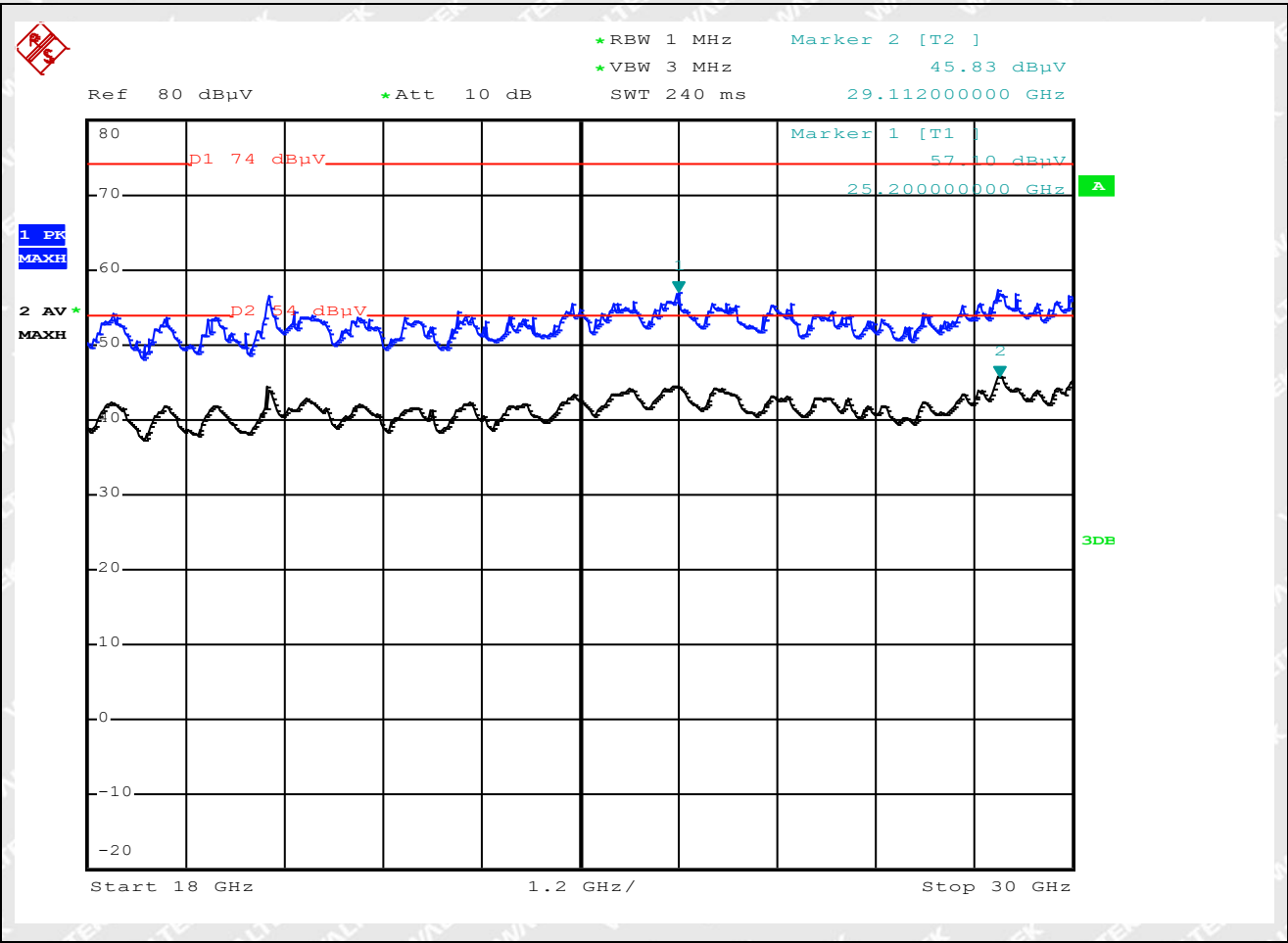


No.	Frequency (MHz)	Reading (dBuV)	Correct (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree ()	Height (cm)	Remark
1	4641.172	50.90	-12.90	38.00	74.00	-36.00	-	-	peak
2	6023.218	50.62	-8.73	41.89	74.00	-32.11	-	-	peak
3	9246.582	49.39	-3.88	45.51	74.00	-28.49	-	-	peak



Above 18GHz

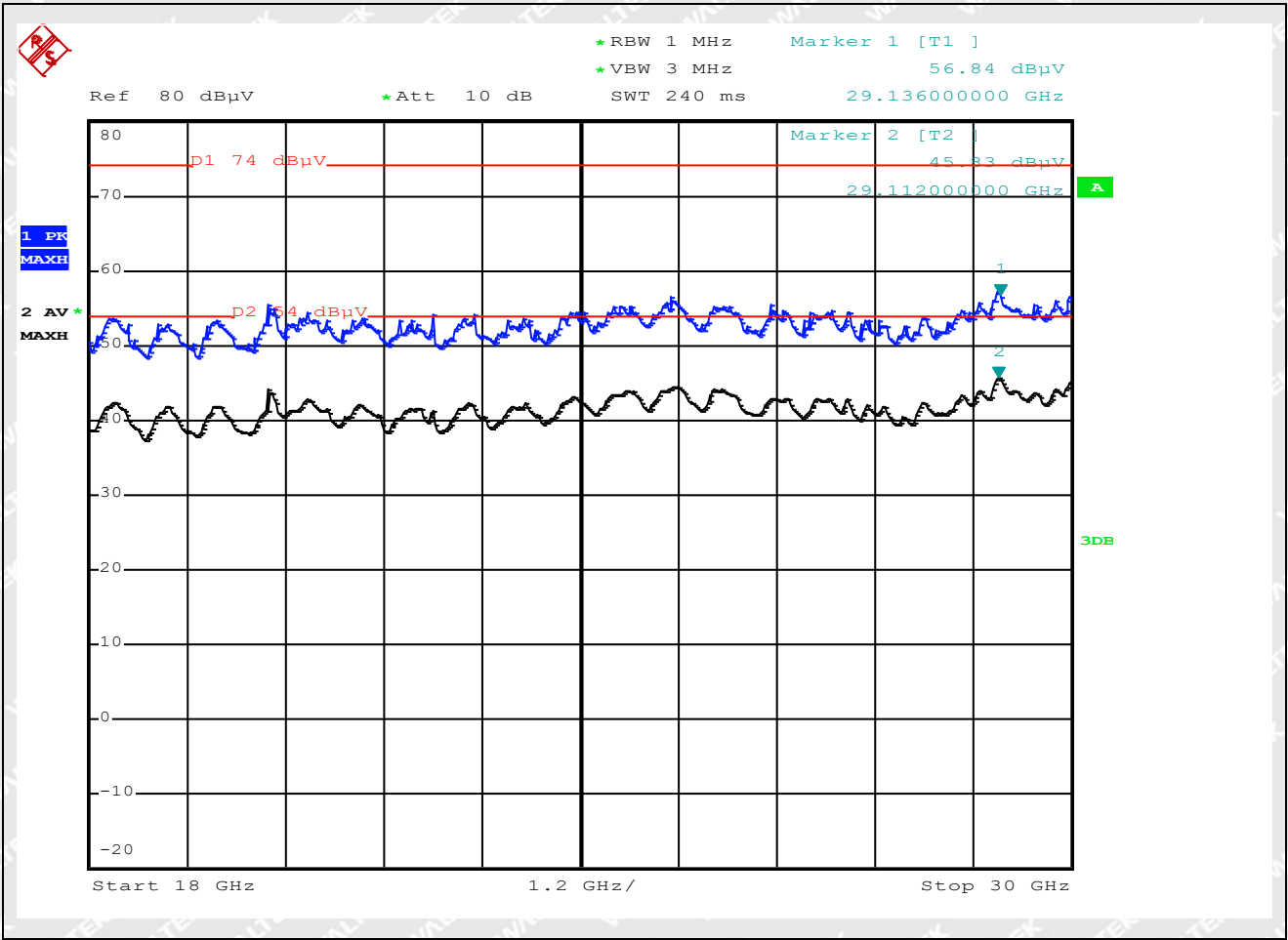
Test mode:	TM1	Polarity:	Horizontal
------------	-----	-----------	------------



No.	Frequency (GHz)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree ()	Height (cm)	Remark
1	25.300	57.10	74.00	-16.90	-	-	peak
2	29.112	45.83	54.00	-8.17	-	-	AVG



Test mode:	TM1	Polarity:	Vertical
------------	-----	-----------	----------



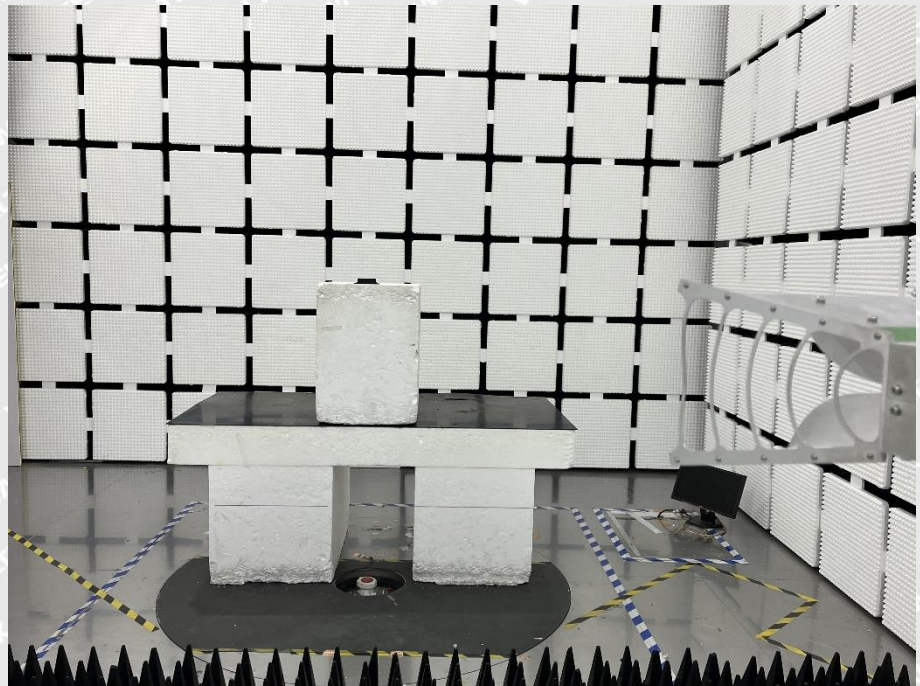
No.	Frequency (GHz)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Degree ()	Height (cm)	Remark
1	29.136	56.84	74.00	-17.16	-	-	peak
2	29.113	45.83	54.00	-8.17	-	-	AVG

Remark: '-' Means' the test Degree and Height are not recorded by the test software and only show the worst case in the test report.

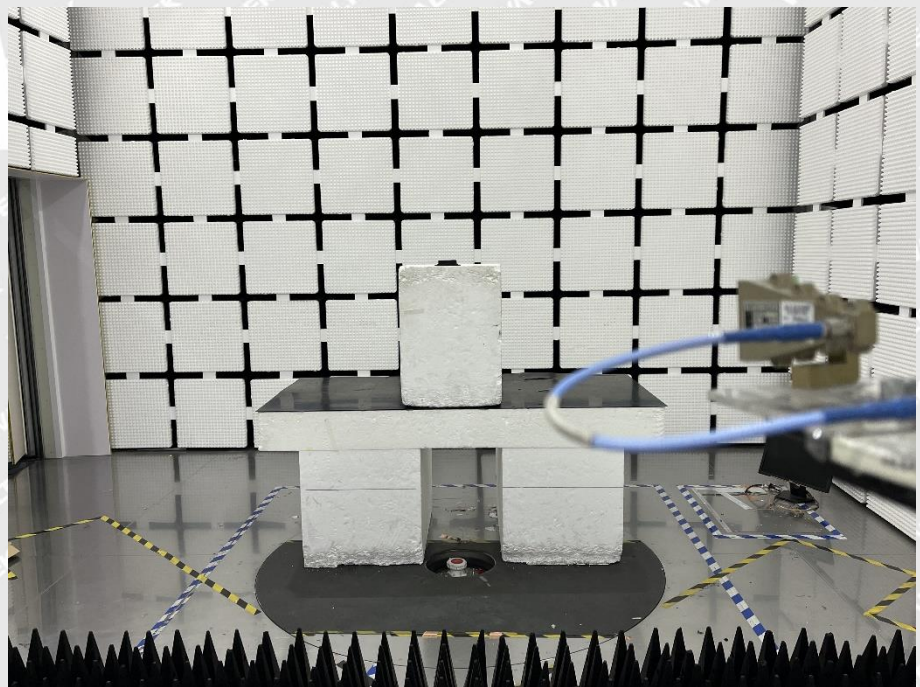


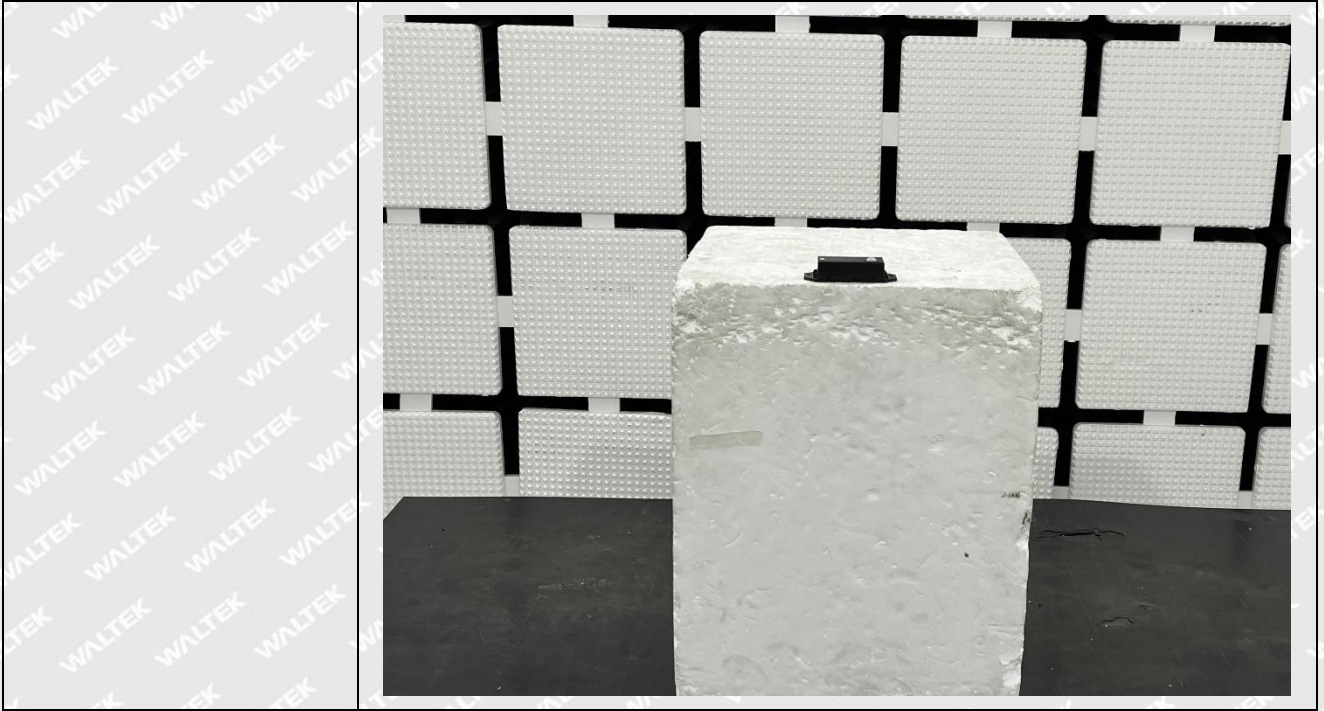
EXHIBIT 1 - TEST SETUP PHOTOGRAPHS

**Radiation Emission Test
View (Above 1GHz)**



**Radiation Emission Test
View (Above 18GHz)**





***** END OF REPORT *****

WALTEK